HEIWA.017AUS PATENT

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Hideyuki Oshima ) Group Art Unit

Serial No. : New U.S. National Stage

Application

Filed : International Filing Date

December 26, 2003

For : SEMICONDUCTOR TEST

**APPARATUS** 

Examiner : Unknown

## PRELIMINARY AMENDMENT

Hon. Commissioner of Patents and Trademarks Alexandria, VA 22313-1450

## Dear Sir:

This amendment is submitted for the above-identified patent application for correcting the forms of the claims in the national stage of the International Application. Please make the following changes.